











LM5114

SNVS790F - JANUARY 2012-REVISED NOVEMBER 2015

LM5114 Single 7.6-A Peak Current Low-Side Gate Driver

Features

- Independent Source and Sink Outputs for Controllable Rise and Fall Times
- 4-V to 12.6-V Single Power Supply
- 7.6-A/1.3-A Peak Sink and Source Drive Current
- 0.23-Ω Open-drain Pulldown Sink Output
- 2-Ω Open-drain Pullup Source Output
- 12-ns (Typical) Propagation Delay
- Matching Delay Time Between Inverting and Noninverting Inputs
- TTL/CMOS Logic Inputs
- 0.68-V Input Hysteresis
- Up to 14-V Logic Inputs (Regardless of VDD Voltage)
- Low Input Capacitance: 2.5-pF (Typical)
- -40°C to 125°C Operating Temperature Range
- Pin-to-Pin Compatible With MAX5048
- 6-Pin SOT-23

Applications

- **Boost Converters**
- Flyback and Forward Converters
- Secondary Synchronous FETs Drive in Isolated **Topologies**
- Motor Control

3 Description

The LM5114 is designed to drive low-side MOSFETs in boost-type configurations or to drive secondary synchronous MOSFETs in isolated topologies. With strong sink current capability, the LM5114 can drive multiple FETs in parallel. The LM5114 also has the features necessary to drive low-side enhancement mode Gallium Nitride (GaN) FETs. The LM5114 provides inverting and noninverting inputs to satisfy requirements for inverting and Noninverting gate drive in a single device type. The inputs of the LM5114 are TTL/CMOS Logic compatible and withstand input voltages up to 14 V regardless of the VDD voltage. The LM5114 has split gate outputs, providing flexibility to adjust the turnon and turnoff strength independently. The LM5114 has fast switching speed and minimized propagation delays, facilitating highfrequency operation. The LM5114 is available in a 6pin SOT-23 package and a 6-pin WSON package with an exposed pad to aid thermal dissipation.

Device Information⁽¹⁾

| PART NUMBER | PACKAGE | BODY SIZE (NOM) | | |
|-------------|------------|-------------------|--|--|
| LM5114 | SOT-23 (6) | 2.90 mm × 1.60 mm | | |
| | WSON (6) | 3.00 mm × 3.00 mm | | |

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Block Diagram

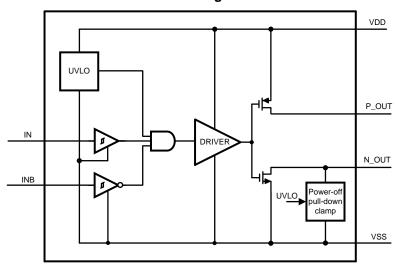




Table of Contents

| 1 | Features 1 | 8.3 Feature Description | 12 |
|---|--------------------------------------|---|----|
| 2 | Applications 1 | 8.4 Device Functional Modes | 12 |
| 3 | Description 1 | 9 Application and Implementation | 13 |
| 4 | Revision History2 | 9.1 Application Information | 13 |
| 5 | Device Comparison Table | 9.2 Typical Application | 13 |
| 6 | Pin Configuration and Functions | 9.3 System Examples | 17 |
| 7 | Specifications4 | 10 Power Supply Recommendations | 18 |
| ′ | 7.1 Absolute Maximum Ratings | 11 Layout | 18 |
| | 7.1 Absolute Maximum Ratings | 11.1 Layout Guidelines | |
| | 7.3 Recommended Operating Conditions | 11.2 Layout Example | 18 |
| | 7.4 Thermal Information | 12 Device and Documentation Support | 19 |
| | 7.5 Electrical Characteristics | 12.1 Community Resources | |
| | 7.6 Switching Characteristics 6 | 12.2 Trademarks | 19 |
| | 7.7 Typical Characteristics | 12.3 Electrostatic Discharge Caution | 19 |
| 8 | Detailed Description | 12.4 Glossary | 19 |
| | 8.1 Overview | 13 Mechanical, Packaging, and Orderable Information | 19 |
| | 8.2 Functional Block Diagram | | |

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision E (March 2013) to Revision F

Page

Added Pin Configuration and Functions section, ESD Ratings table, Thermal Information table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section

Changes from Revision D (August 2012) to Revision E

Page

Submit Documentation Feedback

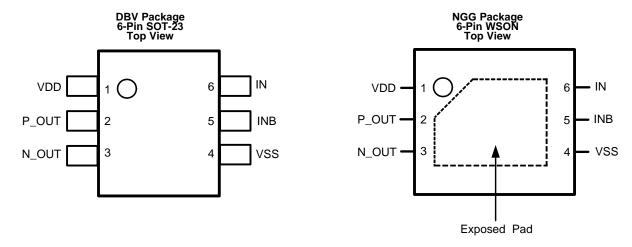
Copyright © 2012–2015, Texas Instruments Incorporated



Device Comparison Table

| BASE PART NUMBER | INPUT THRESHOLDS |
|------------------|------------------|
| LM5114A | CMOS |
| LM5114B | TTL |

6 Pin Configuration and Functions



Pin Functions

| | PIN | | | DESCRIPTION |
|-------|--------|----------|-----|--|
| NAME | SOT-23 | WSON | 1/0 | DESCRIPTION |
| IN | 6 | 6 | I | Noninverting logic input Connect to VDD when not used. |
| INB | 5 | 5 | I | Inverting logic input Connect to VSS when not used. |
| N_OUT | 3 | 3 | 0 | Sink-current output Connect to the gate of the MOSFET with a short, low inductance path. A gate resistor can be used to adjust the turnoff speed. |
| P_OUT | 2 | 2 | 0 | Source-current output Connect to the gate of the MOSFET with a short, low inductance path. A gate resistor can be used to adjust the turnon speed. |
| VDD | 1 | 1 | _ | Gate drive supply Locally decouple to VSS using low ESR/ESL capacitor located as close as possible to the IC. |
| VSS | 4 | 4 | _ | Ground All signals are referenced to this ground. |
| EP | _ | √ | _ | It is recommended that the exposed pad on the bottom of the package is soldered to ground plane on the PC board to aid thermal dissipation. |

Copyright © 2012–2015, Texas Instruments Incorporated



7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

| | MIN | MAX | UNIT |
|---------------------------------------|------|-----------|------|
| VDD to VSS | -0.3 | 14 | V |
| IN, INB to VSS | -0.3 | 14 | V |
| N_OUT to VSS | -0.3 | VDD + 0.3 | V |
| P_OUT to VSS | -0.3 | VDD + 0.3 | V |
| Junction temperature | | 150 | °C |
| Storage temperature, T _{stg} | -55 | 150 | °C |

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

| | | | VALUE | UNIT |
|--------------------|-------------------------|--|-------|------|
| | | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1) | ±2000 | ٧ |
| V _(ESD) | Electrostatic discharge | Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾ | ±1000 | ٧ |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| | MIN | NOM MAX | UNIT |
|----------------------|-----|---------|------|
| VDD | 4 | 12.6 | V |
| Junction temperature | 40 | 125 | °C |

7.4 Thermal Information

| | | LM | LM5114 | | | |
|----------------------|--|--------------|------------|------|--|--|
| | THERMAL METRIC ⁽¹⁾ | DBV (SOT-23) | NGG (WSON) | UNIT | | |
| | | 6 PINS | 6 PINS | | | |
| $R_{\theta JA}$ | Junction-to-ambient thermal resistance | 108.1 | 51.0 | °C/W | | |
| $R_{\theta JC(top)}$ | Junction-to-case (top) thermal resistance | 54.2 | 47.0 | °C/W | | |
| $R_{\theta JB}$ | Junction-to-board thermal resistance | 24.9 | 25.3 | °C/W | | |
| Ψ_{JT} | Junction-to-top characterization parameter | 1.3 | 0.6 | °C/W | | |
| Ψ_{JB} | Junction-to-board characterization parameter | 23.9 | 25.4 | °C/W | | |
| $R_{\theta JC(bot)}$ | Junction-to-case (bottom) thermal resistance | NA | 5.8 | °C/W | | |

 For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

Product Folder Links: LM5114



7.5 Electrical Characteristics

Minimum and Maximum limits are ensured through test, design, or statistical correlation. Typical values represent the most likely parametric norm at $T_J = 25$ °C, and are provided for reference purposes only. Unless otherwise specified, $V_{DD} = 12 \text{ V}^{(1)}$.

| PARAMETER | | TEST CONDITIONS | | MIN | TYP | MAX | UNIT |
|------------------------------|---------------------------------------|--|--|---------------|-------|---------------|----------|
| POWER SUPPLY | | | | | | | |
| V _{DD} | VDD operating voltage | (T _J) range of -40°C to | o 125°C | 4.0 | | 12.6 | V |
| - 00 | | (13) 101190 11 10 0 1 | T _J = 25°C | | 3.6 | | <u> </u> |
| | VDD undervoltage | VDD Rising | (T _J) range of | | 0.0 | | V |
| UVLO | lockout | | -40°C to 125°C | 3.25 | | 4.00 | |
| | VDD undervoltage locko | ut hysteresis | | | 0.4 | | V |
| | | | T _J = 25°C | | 0.95 | | |
| I _{DD} | VDD quiescent current | IN = INB = VDD | (T _{.l}) range of | | | 4.0 | mA |
| | | | -40°C to 125°C | | | 1.9 | |
| N-CHANNEL OUTPU | JT | T | | | | | |
| | | VDD = 10 V, | $T_J = 25^{\circ}C$ | | 0.23 | 0.26 | Ω |
| D (SOT 22.6) | Driver output resistance – pulling | $I_{N-OUT} = -100 \text{ mA}$ | $T_J = 125$ °C | | 0.38 | 0.43 | Ω |
| R _{ON-N} (SOT-23-6) | down | VDD = 4.5 V, | $T_J = 25^{\circ}C$ | | 0.24 | 0.28 | Ω |
| | | $I_{N-OUT} = -100 \text{ mA}$ | TJ = 125°C | | 0.40 | 0.47 | Ω |
| | | VDD = 10 V, | T _J = 25°C | | 0.31 | 0.34 | Ω |
| | Driver output | $I_{N-OUT} = -100 \text{ mA}$ | T _J = 125°C | | 0.46 | 0.51 | Ω |
| | resistance – pulling down | VDD = 4.5 V, | T _J = 25°C | | 0.32 | 0.36 | Ω |
| R _{ON-N} (WSON-6) | down | $I_{N-OUT} = -100 \text{ mA}$ | T _J = 125°C | | 0.48 | 0.55 | Ω |
| | Power-off pulldown resistance | VDD = 0 V, I _{N-OUT} = -10 mA | | | 3.3 | 10 | Ω |
| | Power-off pulldown clamp voltage | VDD = 0 V, I _{N-OUT} = - | | 0.85 | 1.0 | V | |
| | | | T _J = 25°C | | 6.85 | | |
| I _{LK-N} | Output leakage current | N_OUT = VDD | (T _J) range of -40°C to 125°C | | | 20 | μΑ |
| I _{PK-N} | Peak sink current | C _L = 10,000 pF | | | 7.6 | | Α |
| P-CHANNEL OUTPU | JT | | | | | | |
| | | VDD = 10 V, | T _J = 25°C | | 2.00 | 3.00 | Ω |
| | Driver output | $I_{P-OUT} = 50 \text{ mA}$ | T _J = 125°C | | 2.85 | 4.30 | Ω |
| R _{ON-P} (SOT-23-6) | resistance – pulling up | VDD = 4.5 V, | T _J = 25°C | | 2.20 | 3.30 | Ω |
| | | $I_{P-OUT} = 50 \text{ mA}$ | $T_{J} = 125^{\circ}C$ | | 3.10 | 4.70 | Ω |
| | | | T _J = 25°C | | 2.08 | 3.08 | Ω |
| | Driver output | $VDD = 10 V,$ $I_{P-OUT} = 50 \text{ mA}$ | $T_{J} = 125^{\circ}C$ | | 2.93 | 4.38 | Ω |
| R _{ON-P} (WSON-6) | resistance – pulling up | | T _J = 25°C | | 2.28 | 3.38 | Ω |
| | | VDD = 4.5 V, I _{P-OUT} = 50 mA | $T_{J} = 125^{\circ}C$ | | 3.18 | 4.78 | Ω |
| | | | $T_{\rm J} = 25^{\circ}{\rm C}$ | | 0.001 | 4.70 | 1.2 |
| I _{LK-P} | Output leakage current | P_OUT = 0 | (T _J) range of -40°C to 125°C | | 0.001 | 10 | μΑ |
| I _{PK-P} | Peak source current | CL = 10,000 pF | -40 C to 123 C | | 1.3 | | Α |
| LOGIC INPUT | | | | | | ' | |
| | Logic 1 input voltage | LM5114A | (T _J) range of -40°C to 125°C | 0.67 × VDD | | | V |
| VILL | Logic 1 input voltage | h | + | | | | 1.7 |
| V_{IH} | -9 | LM5114B | | 2.4 | | | V |
| V _{IH} | Logic 0 input voltage | LM5114A | (T _J) range of -40°C to 125°C | 2.4 | | 0.33 × VDD | V |

⁽¹⁾ Min and Max limits are 100% production tested at 25°C. Limits over the operating temperature range are ensured through correlation using statistical quality control (SQC) methods. Limits are used to calculate Tl's average outgoing quality level (AOQL).

Product Folder Links: LM5114



Electrical Characteristics (continued)

Minimum and Maximum limits are ensured through test, design, or statistical correlation. Typical values represent the most likely parametric norm at $T_J = 25$ °C, and are provided for reference purposes only. Unless otherwise specified, $V_{DD} = 12 \text{ V}^{(1)}$.

| PAF | RAMETER | TEST CO | MIN | TYP | MAX | UNIT | |
|-------------------|------------------------|----------------|--|------|-------|------|----|
| LOGIC INPUT (cont | inued) | | | | | | |
| | Lania innut huatanasia | LM5114A | LM5114A | | 1.6 | | V |
| | Logic-input hysteresis | LM5114B | | 0.68 | | V | |
| V _{HYS} | Logic-input current | INB = VDD or 0 | T _J = 25°C | | 0.001 | | |
| | | | (T _J) range of -40°C to 125°C | | | 10 | μΑ |
| C _{IN} | Input capacitance | | | | 2.5 | | pF |

7.6 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

| | PARAMETER | | TEST CON | DITIONS | MIN | TYP | MAX | UNIT |
|--------------------------|---|----------------------------|----------|--|-----|------|-----|------|
| POWER | SUPPLY | | | <u> </u> | | | | |
| UVLO | VDD undervoltage lockout to output delay time | VDD Risii | ng | | | 300 | | ns |
| SWITCH | ING CHARACTERISTICS FOR VDD = | 10 V | | <u> </u> | | | | |
| | | $C_L = 1000$ |) pF | | | 8 | | ns |
| t _R Rise time | | $C_L = 5000$ |) pF | | | 45 | | ns |
| | | $C_L = 10,0$ | 00 pF | | | 82 | | ns |
| | | $C_L = 1000$ |) pF | | | 3.2 | | ns |
| t _F | Fall time | $C_L = 5000$ |) pF | | | 7.5 | | ns |
| | | $C_L = 10,0$ | 00 pF | | | 12.5 | | ns |
| | | | | $T_J = 25^{\circ}C$ | | 12 | | |
| t _{D-ON} | Turnen proporation delay | C _L = | LM5114A | (T _J) range of -40°C to 125°C | 5 | | 30 | |
| | Turnon propagation delay | 1000 pF | LM5114B | T _J = 25°C | | 12 | | ns |
| | | | | (T _J) range of -40°C to 125°C | 6 | | 25 | |
| | | C _L = 1000 pF | LM5114A | T _J = 25°C | | 12 | | |
| | | | | (T _J) range of -40°C to 125°C | 5 | | 30 | |
| t _{D-OFF} | Turnoff propagation delay | | | T _J = 25°C | | 12 | | ns |
| | | | LM5114B | (T _J) range of –40°C to 125°C | 6 | | 25 | |
| Break-b | efore-make Time | | | | | 2.5 | | ns |
| SWITCH | HING CHARACTERISTICS FOR VDD = | 4.5 V | | | | | | |
| | | $C_L = 1000$ |) pF | | | 12 | | ns |
| t_R | Rise time | C _L = 5000 pF | | | | 41 | | ns |
| | | C _L = 10,000 pF | | | | 74 | | ns |
| | | $C_L = 1000$ |) pF | | | 3.0 | | ns |
| t _F | Fall time | $C_L = 5000$ | | | | 7.0 | | ns |
| | | $C_L = 10,0$ | 00 pF | | | 11.3 | | ns |
| | | | | $T_J = 25^{\circ}C$ | | | 36 | |
| to ov | Turnon propagation delay | C _L = | LM5114A | (T _J) range of -40°C to 125°C | 5 | | 17 | ns |
| t _{D-ON} | rumon propagation delay | 1000 pF | | T _J = 25°C | | | 27 | 115 |
| | | LM5114B | | (T _J) range of -40°C to 125°C | 8 | | 14 | |

Submit Documentation Feedback

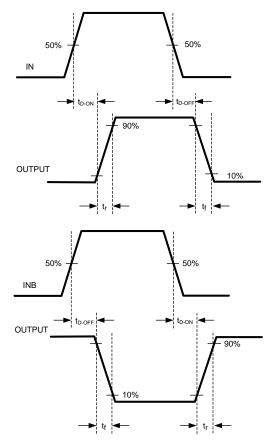
Copyright © 2012–2015, Texas Instruments Incorporated



Switching Characteristics (continued)

over operating free-air temperature range (unless otherwise noted)

| | PARAMETER | | TEST CONDITIONS | | MIN | TYP | MAX | UNIT | |
|---|---------------------------|------------------|-----------------|--|-----|-----|-----|------|--|
| SWITCHING CHARACTERISTICS FOR VDD = 4.5 V (continued) | | | | | | | | | |
| | | | | T _J = 25°C | | | 36 | | |
| | Turneff prepagation delay | C _I = | LM5114A | (T _J) range of -40°C to 125°C | 5 | | 17 | | |
| t _{D-OFF} | Turnoff propagation delay | 1000 pF | LM5114B | T _J = 25°C | | | 27 | ns | |
| | | | | (T _J) range of -40°C to 125°C | 8 | | 14 | | |
| Break-be | efore-make time | | | | | 4.2 | | ns | |



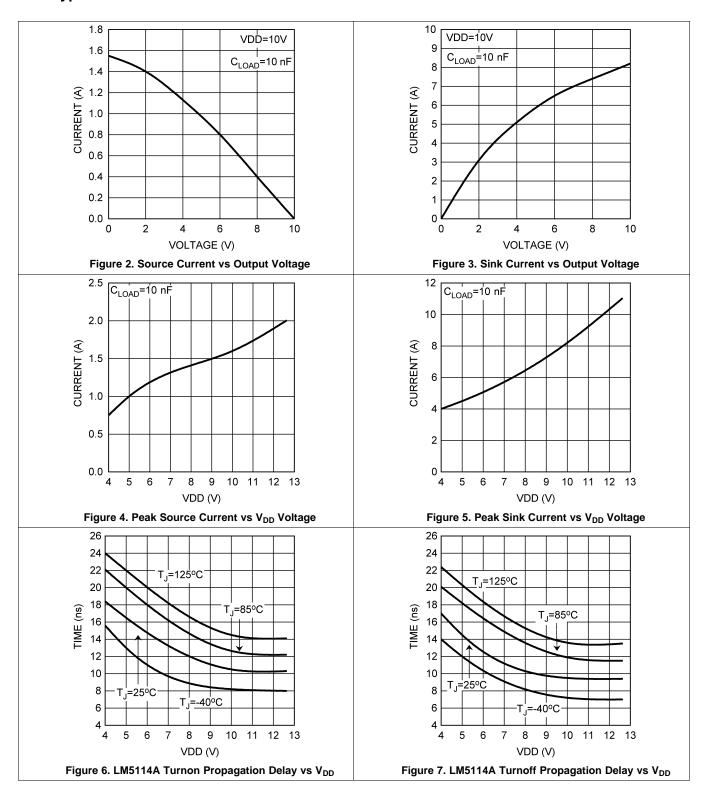
Note: P_OUT and N_OUT are tied together.

Figure 1. Timing Diagram

Submit Documentation Feedback

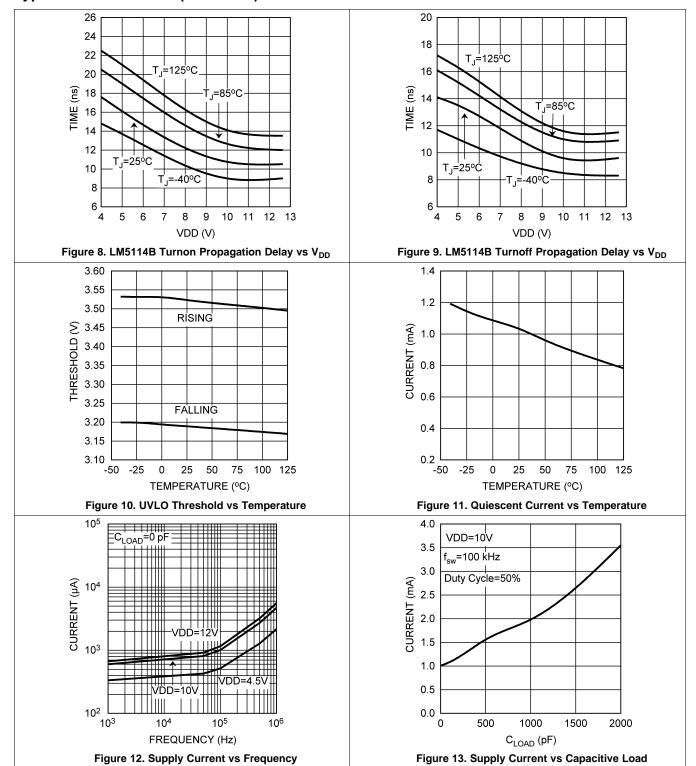
TEXAS INSTRUMENTS

7.7 Typical Characteristics



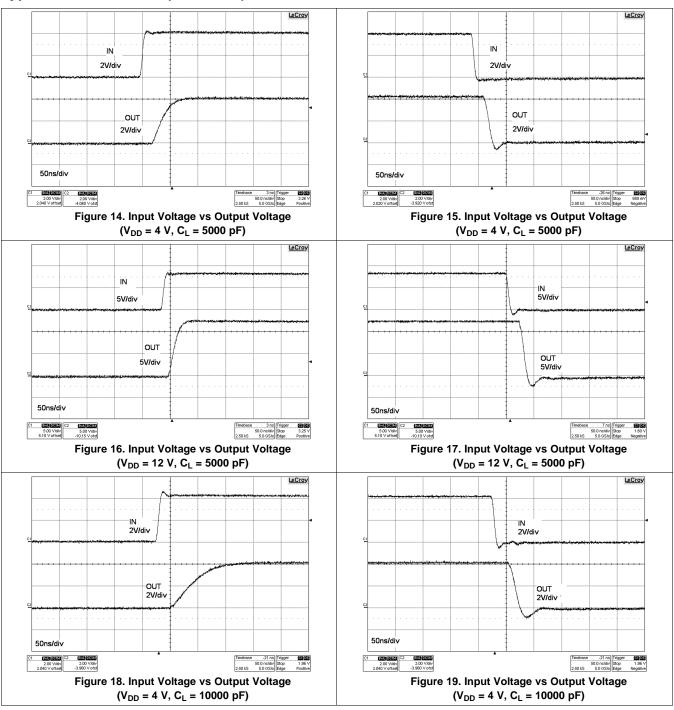


Typical Characteristics (continued)



TEXAS INSTRUMENTS

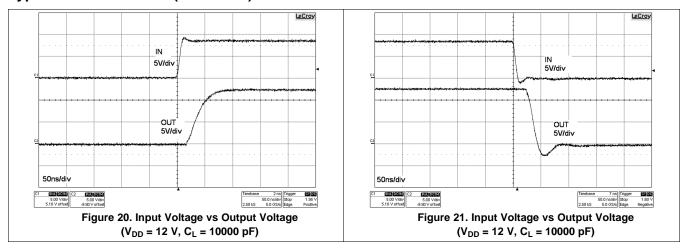
Typical Characteristics (continued)



Submit Documentation Feedback



Typical Characteristics (continued)



Submit Documentation Feedback

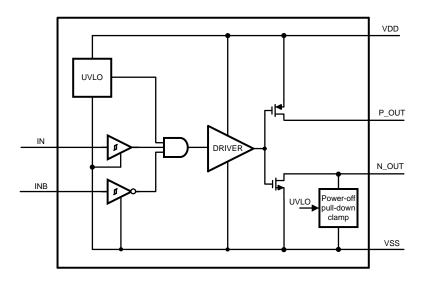


8 Detailed Description

8.1 Overview

The LM5114 is designed to drive low-side MOSFETs in boost-type configurations or to drive secondary synchronous MOSFETs in isolated topologies. The LM5114 offers both inverting and Noninverting inputs to satisfy requirements for inverting and Noninverting gate drive in a single device type.

8.2 Functional Block Diagram



8.3 Feature Description

The LM5114 is a single low-side gate driver with 7.6-A/1.3-A peak sink/source drive current capability. Inputs of the LM5114 are TTL Logic compatible and can withstand the input voltages up to 14-V regardless of the VDD voltage. This allows inputs of the LM5114 to be connected directly to most PWM controllers. The split outputs of the LM5114 offer flexibility to adjust the turnon and turnoff speed independently by adding additional impedance in either the turnon path or the turnoff path.

The LM5114 includes an under-voltage lockout (UVLO) circuit. When the VDD voltage is below the UVLO threshold voltage, the IN and INB inputs are ignored, and if there is sufficient VDD voltage, the output NMOS is turned on to pull the N_OUT low. In addition, the LM5114 has an internal PNP transistor in parallel with the output NMOS. Under the UVLO condition, the PNP transistor will be on and clamp the N_OUT voltage below 1 V.

Under the UVLO condition, the PNP transistor will be on and clamp the N_OUT voltage below 1 V. This feature ensures the N_OUT remaining low when VDD voltage is not sufficient to enhance the output NMOS. The LM5114 has the features necessary to drive low-side enhancement mode GaN FETs. Due to the fast switching speed and relatively low gate voltage of enhancement mode GaN FETs, PCB layout is crucial to achieve reliable operation. Refer to *Layout* for details.

8.4 Device Functional Modes

Table 1. Truth Table

| IN | INB | P_OUT | N_OUT |
|----|-----|-------|-------|
| L | L | OPEN | L |
| L | Н | OPEN | L |
| Н | L | Н | OPEN |
| Н | Н | OPEN | L |

Product Folder Links: LM5114



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The LM5114 has the features necessary to drive low-side enhancement mode GaN FETs. Due to the fast switching speed and relatively low gate voltage of enhancement mode GaN FETs, PCB layout is crucial to achieve reliable operation. Refer to Figure 32 for details.

9.2 Typical Application

Boost DC-DC converter using a 100-V enhancement mode GaN FET (EPC2001) as the boost power switch. The control circuitry is implemented with the LM5114, a 100-V current mode PWM controller.

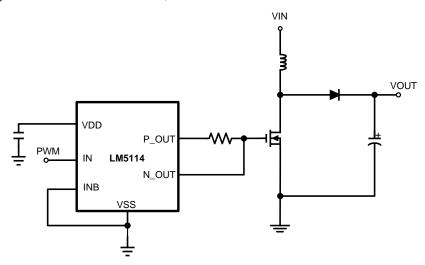


Figure 22. Simplified Boost Converter

Copyright © 2012–2015, Texas Instruments Incorporated

Submit Documentation Feedback

(3)



Typical Application (continued)

9.2.1 Design Requirements

See Table 2 for the parameter and values.

Table 2. Operating Parameters

| PARAMETER | VALUE | | | |
|-------------------------|-------------------|--|--|--|
| Input Operating Voltage | 24 V to 66 V | | | |
| Output Voltage | 75 V | | | |
| Output Current | 2 A | | | |
| Measured Efficiency | 97% @ at 48 V 2 A | | | |
| Frequency of Operation | 500 kHz | | | |

9.2.1.1 Power Dissipation

It is important to keep the power consumption of the driver below the maximum power dissipation limit of the package at the operating temperature. The total power dissipation of the LM5114 is the sum of the gate charge losses and the losses in the driver due to the internal CMOS stages used to buffer the output as well as the power losses associated with the quiescent current.

The gate charge losses can be calculated with the total input gate charge as in Equation 1 and Equation 2:

$$P_{g} = Q_{g} \times V_{DD} \times F_{sw}$$
(1)

or

$$P_g = C_{LOAD} \times V_{DD}^2 \times F_{SW}$$

where

The power dissipation associated with the internal circuit operation of the driver can be estimated with the characterization curves of the LM5114. For a given ambient temperature, the maximum allowable power loss of the IC can be defined as Equation 3:

$$P = \frac{\left(T_{J} - T_{A} \right)}{\theta_{JA}}$$

where

external gate resistor.

P is the total power dissipation of the driver

This power PG is dissipated in the resistive elements of the circuit when the MOSFET/IGBT is being turned on and off. Half of the total power is dissipated when the load capacitor is charged during turnon, and the other half is dissipated when the load capacitor is discharged during turnoff. When no external gate resistor is employed between the driver and MOSFET/IGBT, this power is completely dissipated inside the driver package. With the use of external gate-drive resistors, the power dissipation is shared between the internal resistance of driver and

Copyright © 2012–2015, Texas Instruments Incorporated Product Folder Links: *LM5114*



9.2.1.1.1 Gate Drive

The enhancement mode GaN FETs have small gate capacitance and low threshold gate voltage. Therefore GaN FETs are prone to gate oscillations induced by PCB parasitic elements. It is necessary to place the driver as close to the GaN FET as possible to minimize the stray inductance. Gate resistors can be used to damp the oscillations and to adjust the switching speed. The LM5114 has split outputs, providing flexibility to adjust the turnon and turnoff strength independently. In the evaluation board, $1.5-\Omega$ and $2.7-\Omega$ gate resistors are used in the turnon and turnoff path respectively.

9.2.2 Detailed Design Procedure

The LM5114 has the features necessary to drive low-side enhancement mode GaN FETs. Due to the fast switching speed and relatively low gate voltage of enhancement mode GaN FETs, PCB layout is crucial to achieve reliable operation.

Generally, the switching speed of the power switch during turnon and turnoff should be as fast as possible in order to minimize switching power losses. The gate driver device must be able to provide the required peak current for achieving the targeted switching speeds with the targeted power switch. The system requirement for the switching speed is typically described in terms of the slew rate of the drain-to-source voltage of the power FET (such as dVDS/dt).

For example, the system requirement in this application might state that a EPC2001 GaN FET must be turned on with a dVDS/dt of 20 V/ns or higher with a DC bus voltage of 75 V.

This requirement means that the entire drain-to-source voltage swing during the FET turnon event (from 75 V in the OFF state to VDS(on) in on state) must be completed in approximately 3.75 ns or less. When the drain-to-source voltage swing occurs, the Miller charge of the power FET (QGD parameter in EPC2001 data sheet is 2.2 nC typical) is supplied by the peak current of gate driver. To achieve the targeted dVDS/dt, the gate driver must be capable of providing the QGD charge in 3.75 ns or less. In other words a peak current of 0.586 A (= 2.2 nC / 2 ns) or higher must be provided by the gate driver.

The LM5114 gate driver is capable of providing 1.3-A peak sourcing current which clearly exceeds the design requirement and has the capability to meet the switching speed needed. The 2.2x overdrive capability provides an extra margin against part-to-part variations in the QGD parameter of the power MOSFET along with additional flexibility to insert external gate resistors and fine tune the switching speed for efficiency versus EMI optimizations. However, in practical designs the parasitic trace inductance in the gate drive circuit of the PCB will have a definitive role to play on the FET switching speed.

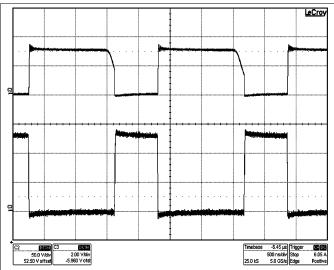
The effect of this trace inductance is to limit the dl/dt of the output current pulse of the gate driver. In order to illustrate this, consider output current pulse waveform from the gate driver to be approximated to a triangular profile, where the area under the triangle (½ x IPEAK x time) would equal the total gate charge of the power FET (QG parameter in the EPC2001 GaNFET datasheet = 8 nC typical). If the parasitic trace inductance limits the dl/dt then a situation may occur in which the full peak current capability of the gate driver is not fully achieved in the time required to deliver the QG required for the GaNFET switching. In other words the time parameter in the equation would dominate and the IPEAK value of the current pulse would be much less than the true peak current capability of the device, while the required QG is still delivered.

Because of this, the desired switching speed may not be realized, even when theoretical calculations indicate the gate driver is capable of achieving the targeted switching speed. Thus, placing the gate driver device very close to the power FET and designing a tight gate drive-loop with minimal PCB trace inductance is important to realize the full peak-current capability of the gate driver.

Product Folder Links: LM5114

TEXAS INSTRUMENTS

9.2.3 Application Curves



Conditions:

Input Voltage = 48 VDC, Load Current = 2 A

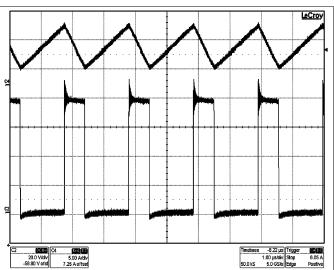
Traces:

Top Trace: Switch-node voltage, Volt/div = 50 V

Bottom Trace: Gate-Source Voltage of GaN FET, Volt/div = 2 V

Bandwidth Limit = 600 MHz Horizontal Resolution = 500 ns/div

Figure 23. Gate-Source Voltage



Conditions:

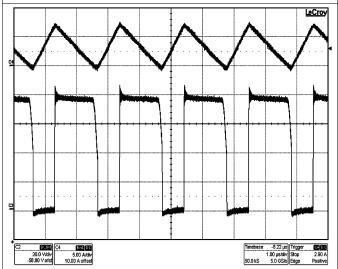
Input Voltage = 24 VDC, Load Current = 2 A

Traces:

Top Trace: Inductor Current, Amp/div = 5 A Bottom Trace: Switch-Node Voltage, Volt/div = 20 V

Bandwidth Limit = 600 MHz Horizontal Resolution = 1 µs/div

Figure 24. Switching Node Voltage $V_{IN} = 24 \text{ V}$, Load Current = 2 A





Input Voltage = 48 VDC

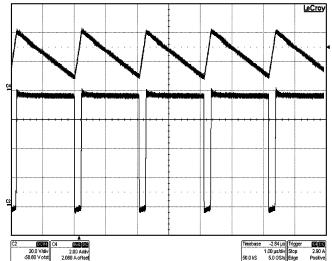
Load Current = 2 A

Traces:

Top Trace: Inductor Current, Amps/div = 5 A
Bottom Trace: Switch-Node Voltage, Volt/div = 20 V

Bandwidth Limit = 600 MHz Horizontal Resolution = 1 µs/div

Figure 25. Switching Node Voltage V_{IN} = 48 V, Load Current = 2 A



Conditions:

Input Voltage = 66 VDC

Load Current = 2 A

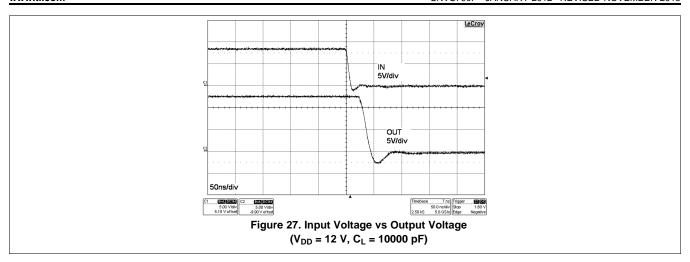
Traces:

Top Trace: Inductor Current, Amp/div = 5 A
Bottom Trace: Switch-Node Voltage, Volt/div = 20 V

Bandwidth Limit = 600 MHz Horizontal Resolution = 1 µs/div

Figure 26. Switching Node Voltage V_{IN} = 66 V, Load Current = 2 A





9.3 System Examples

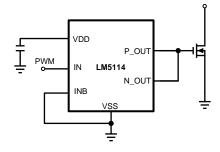


Figure 28. Noninverting Application

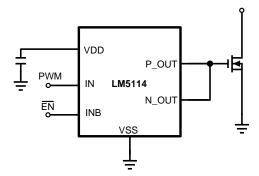


Figure 30. Noninverting Application With Enable Pin

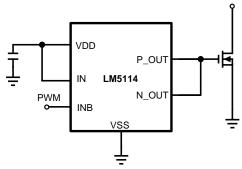


Figure 29. Inverting Application

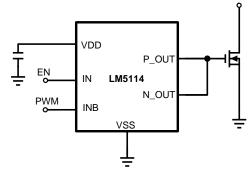


Figure 31. Inverting Application With Enable Pin



10 Power Supply Recommendations

A low-ESR/ESL ceramic capacitor must be connected close to the IC, between V_{DD} and V_{SS} pins to support the high peak current being drawn from V_{DD} during turnon of the FETs. It is most desirable to place the V_{DD} decoupling capacitor on the same side of the PC board as the driver. The inductance of via holes can impose excessive ringing on the IC pins.

11 Layout

11.1 Layout Guidelines

Attention must be given to board layout when using LM5114. Some important considerations include the following:

- The first priority in designing the layout of the driver is to confine the high peak currents that charge and discharge the FETs gate into a minimal physical area. This will decrease the loop inductance and minimize noise issues on the gate.
- To reduce the loop inductance, the driver should be placed as close as possible to the FETs. The gate trace
 to and from the FETs are recommended to be placed closely side by side, or directly on top of one another.
- The parasitic source inductance, along with the gate capacitor and the driver pulldown path, can form a LCR resonant tank, resulting in gate voltage oscillations. An optional resistor or ferrite bead can be used to damp the ringing.

11.2 Layout Example

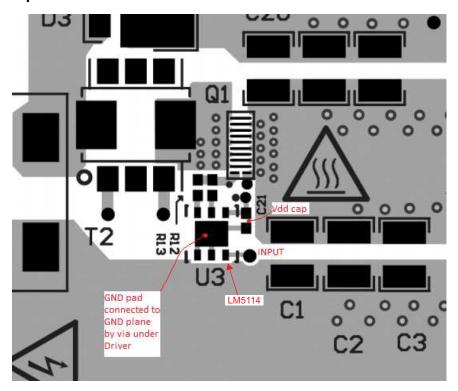


Figure 32. Layout Example

Submit Documentation Feedback



12 Device and Documentation Support

12.1 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

12.2 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

12.3 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

12.4 Glossary

SLYZ022 — TI Glossarv.

This glossary lists and explains terms, acronyms, and definitions.

Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Copyright © 2012-2015, Texas Instruments Incorporated





6-Feb-2020

PACKAGING INFORMATION

| Orderable Device | Status | Package Type | _ | Pins | _ | Eco Plan | Lead/Ball Finish | MSL Peak Temp | Op Temp (°C) | Device Marking | Samples |
|---------------------|--------|--------------|---------|------|------|----------------------------|------------------|--------------------|--------------|----------------|---------|
| | (1) | | Drawing | | Qty | (2) | (6) | (3) | | (4/5) | |
| LM5114AMF/NOPB | ACTIVE | SOT-23 | DBV | 6 | 1000 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | SL2A | Samples |
| LM5114AMF/S7003109 | ACTIVE | SOT-23 | DBV | 6 | 1000 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | SL2A | Samples |
| LM5114AMFX/NOPB | ACTIVE | SOT-23 | DBV | 6 | 3000 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | SL2A | Samples |
| LM5114AMFX/S7003103 | ACTIVE | SOT-23 | DBV | 6 | 3000 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | SL2A | Samples |
| LM5114ASD/NOPB | ACTIVE | WSON | NGG | 6 | 1000 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | 5114A | Samples |
| LM5114ASDX/NOPB | ACTIVE | WSON | NGG | 6 | 4500 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | 5114A | Samples |
| LM5114BMF/NOPB | ACTIVE | SOT-23 | DBV | 6 | 1000 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | SJ4B | Samples |
| LM5114BMF/S7003094 | ACTIVE | SOT-23 | DBV | 6 | 1000 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | SJ4B | Samples |
| LM5114BMF/S7003110 | ACTIVE | SOT-23 | DBV | 6 | 1000 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | SJ4B | Samples |
| LM5114BMFX/NOPB | ACTIVE | SOT-23 | DBV | 6 | 3000 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | SJ4B | Samples |
| LM5114BMFX/S7003094 | ACTIVE | SOT-23 | DBV | 6 | 3000 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | SJ4B | Samples |
| LM5114BSD/NOPB | ACTIVE | WSON | NGG | 6 | 1000 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | 5114B | Samples |
| LM5114BSDX/NOPB | ACTIVE | WSON | NGG | 6 | 4500 | Green (RoHS & no Sb/Br) | SN | Level-1-260C-UNLIM | -40 to 125 | 5114B | Samples |

⁽¹⁾ The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.



PACKAGE OPTION ADDENDUM

6-Feb-2020

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

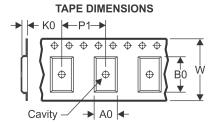
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 20-Dec-2016

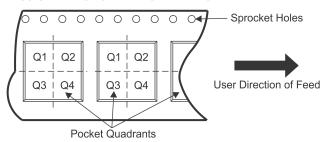
TAPE AND REEL INFORMATION





| Α0 | Dimension designed to accommodate the component width |
|----|---|
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

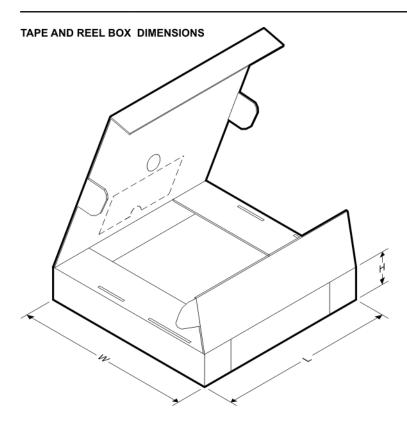


*All dimensions are nominal

| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|---------------------|-----------------|--------------------|---|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| LM5114AMF/NOPB | SOT-23 | DBV | 6 | 1000 | 178.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q3 |
| LM5114AMF/S7003109 | SOT-23 | DBV | 6 | 1000 | 178.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q2 |
| LM5114AMFX/NOPB | SOT-23 | DBV | 6 | 3000 | 178.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q3 |
| LM5114AMFX/S7003103 | SOT-23 | DBV | 6 | 3000 | 178.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q2 |
| LM5114ASD/NOPB | WSON | NGG | 6 | 1000 | 178.0 | 12.4 | 3.3 | 3.3 | 1.0 | 8.0 | 12.0 | Q1 |
| LM5114ASDX/NOPB | WSON | NGG | 6 | 4500 | 330.0 | 12.4 | 3.3 | 3.3 | 1.0 | 8.0 | 12.0 | Q1 |
| LM5114BMF/NOPB | SOT-23 | DBV | 6 | 1000 | 178.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q3 |
| LM5114BMF/S7003094 | SOT-23 | DBV | 6 | 1000 | 178.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q2 |
| LM5114BMF/S7003110 | SOT-23 | DBV | 6 | 1000 | 178.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q2 |
| LM5114BMFX/NOPB | SOT-23 | DBV | 6 | 3000 | 178.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q3 |
| LM5114BMFX/S7003094 | SOT-23 | DBV | 6 | 3000 | 178.0 | 8.4 | 3.2 | 3.2 | 1.4 | 4.0 | 8.0 | Q2 |
| LM5114BSD/NOPB | WSON | NGG | 6 | 1000 | 178.0 | 12.4 | 3.3 | 3.3 | 1.0 | 8.0 | 12.0 | Q1 |
| LM5114BSDX/NOPB | WSON | NGG | 6 | 4500 | 330.0 | 12.4 | 3.3 | 3.3 | 1.0 | 8.0 | 12.0 | Q1 |

PACKAGE MATERIALS INFORMATION

www.ti.com 20-Dec-2016

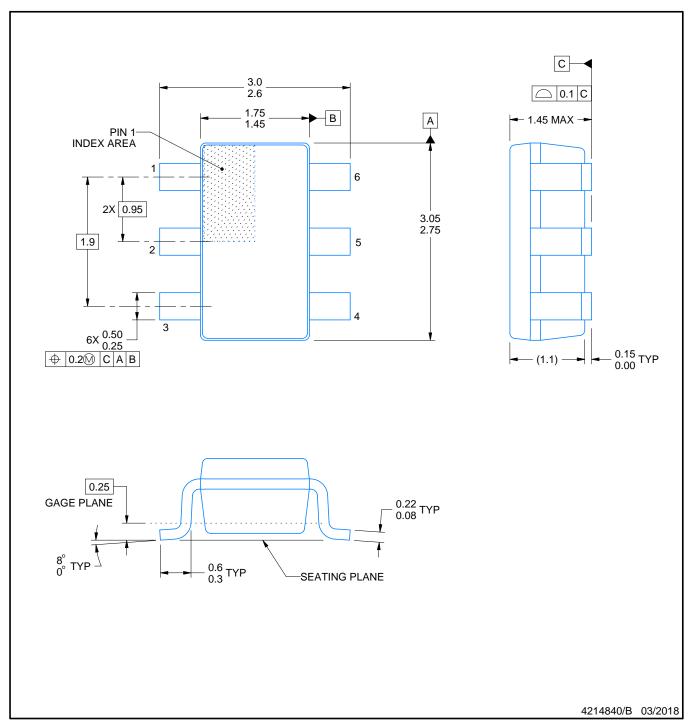


*All dimensions are nominal

| All dimensions are nominal | | | | | | | |
|----------------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| LM5114AMF/NOPB | SOT-23 | DBV | 6 | 1000 | 210.0 | 185.0 | 35.0 |
| LM5114AMF/S7003109 | SOT-23 | DBV | 6 | 1000 | 210.0 | 185.0 | 35.0 |
| LM5114AMFX/NOPB | SOT-23 | DBV | 6 | 3000 | 210.0 | 185.0 | 35.0 |
| LM5114AMFX/S7003103 | SOT-23 | DBV | 6 | 3000 | 210.0 | 185.0 | 35.0 |
| LM5114ASD/NOPB | WSON | NGG | 6 | 1000 | 210.0 | 185.0 | 35.0 |
| LM5114ASDX/NOPB | WSON | NGG | 6 | 4500 | 367.0 | 367.0 | 35.0 |
| LM5114BMF/NOPB | SOT-23 | DBV | 6 | 1000 | 210.0 | 185.0 | 35.0 |
| LM5114BMF/S7003094 | SOT-23 | DBV | 6 | 1000 | 210.0 | 185.0 | 35.0 |
| LM5114BMF/S7003110 | SOT-23 | DBV | 6 | 1000 | 210.0 | 185.0 | 35.0 |
| LM5114BMFX/NOPB | SOT-23 | DBV | 6 | 3000 | 210.0 | 185.0 | 35.0 |
| LM5114BMFX/S7003094 | SOT-23 | DBV | 6 | 3000 | 210.0 | 185.0 | 35.0 |
| LM5114BSD/NOPB | WSON | NGG | 6 | 1000 | 210.0 | 185.0 | 35.0 |
| LM5114BSDX/NOPB | WSON | NGG | 6 | 4500 | 367.0 | 367.0 | 35.0 |



SMALL OUTLINE TRANSISTOR



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

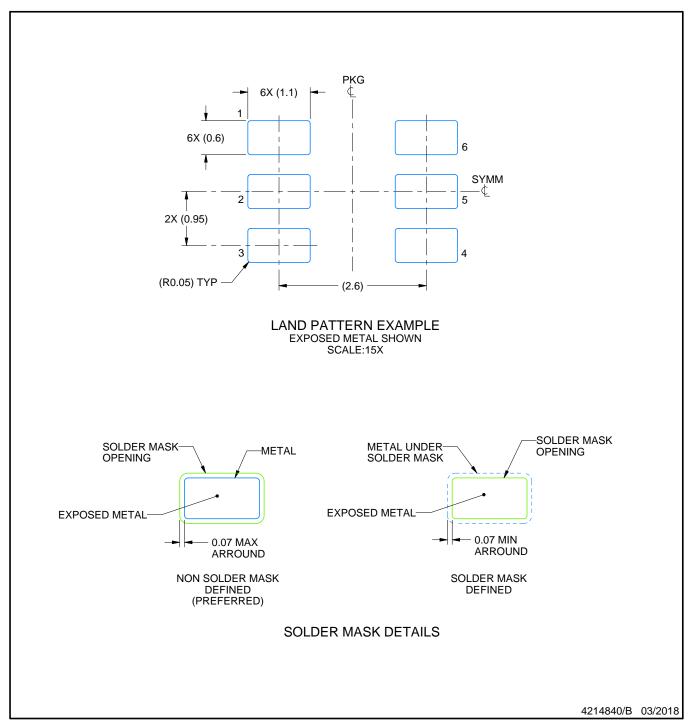
 2. This drawing is subject to change without notice.

 3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.

- 4. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation. 5. Refernce JEDEC MO-178.



SMALL OUTLINE TRANSISTOR



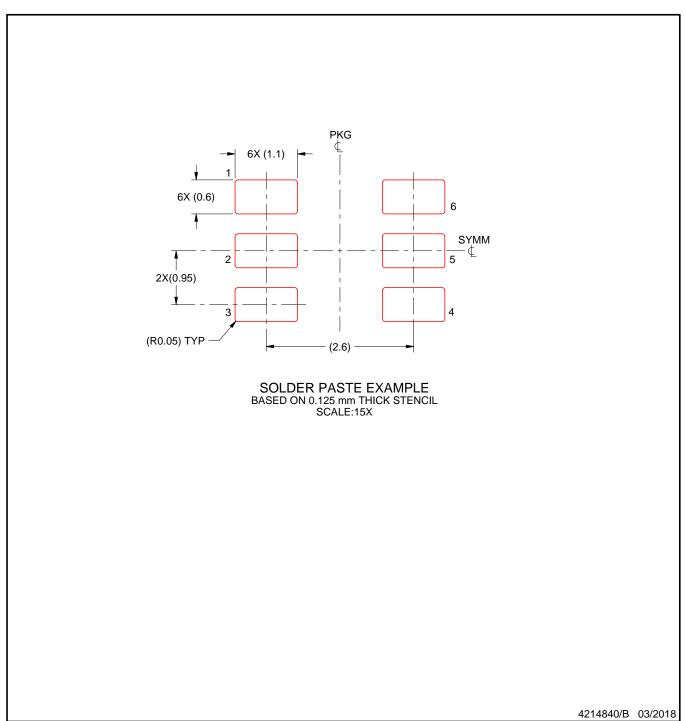
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



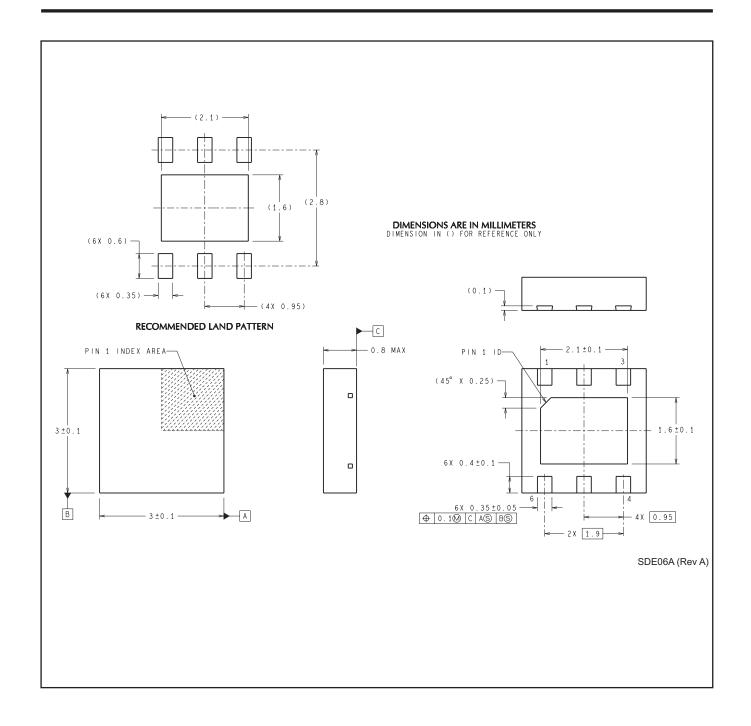
SMALL OUTLINE TRANSISTOR



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

Tl's products are provided subject to Tl's Terms of Sale (www.ti.com/legal/termsofsale.html) or other applicable terms available either on ti.com or provided in conjunction with such Tl products. Tl's provision of these resources does not expand or otherwise alter Tl's applicable warranties or warranty disclaimers for Tl products.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2020, Texas Instruments Incorporated